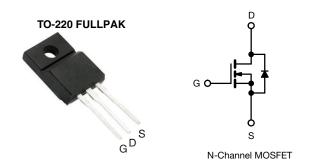
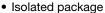
Vishay Siliconix

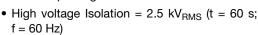
Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	200				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 0.80				
Q _g max. (nC)	14				
Q _{gs} (nC)	3.0				
Q _{gd} (nC)	7.9				
Configuration	Single				

FEATURES







- Sink to lead creepage distance = 4.8 mm
- Dynamic dV/dt rating
- · Low thermal resistance
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI620GPbF

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V_{DS}	200	V
Gate-source voltage			V_{GS}	± 20	7 v
Continuous drain current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I _D	4.1	
Continuous drain current		T _C = 100 °C		2.6	А
Pulsed drain current ^a			I _{DM}	16	
Linear derating factor				0.24	W/°C
Single pulse avalanche energy b			E _{AS}	100	mJ
Repetitive avalanche current a			I _{AR}	4.1	Α
Repetitive avalanche energy a			E _{AR}	3.0	mJ
Maximum power dissipation $T_C = 25 ^{\circ}C$			P_{D}	30	W
Peak diode recovery dV/dt ^c			dV/dt	5.0	V/ns
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C
Soldering recommendations (peak temperature) ^d	For 10 s		_	300	
Mounting torque M3 screw				0.6	Nm

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 8.9 mH, R_q = 25 Ω , I_{AS} = 4.1 A (see fig. 12)
- c. $I_{SD} \le 5.2$ A, $dI/dt \le 95$ A/ μ s, $V_{DD} \le V_{DS}$, $T_{J} \le 150$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R_{thJA}	-	65	°C/W	
Maximum junction-to-case (drain)	R_{thJC}	-	4.1	C/ VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-ssource breakdown voltage	V_{DS}	V _{GS} :	= 0 V, I _D = 250 μA	200	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.29	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-source leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zava gata valtaga dvaia avvvant	1	V _{DS} =	= 200 V, V _{GS} = 0 V	-		25	μА
Zero gate voltage drain current	I _{DSS}	V _{DS} = 160 V	⁷ , V _{GS} = 0 V, T _J = 125 °C	-	-	250	
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.5 A ^b	-	-	0.80	Ω
Forward transconductance	9 _{fs}	V _{DS} =	50 V, I _D = 2.5 A ^b	1.5	-	-	S
Dynamic							
Input capacitance	C _{iss}		$V_{GS} = 0 V$,	-	260	-	
Output capacitance	C _{oss}		$V_{DS} = 25 \text{ V},$	=	100	-	pF
Reverse transfer capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	30	-	
Drain to sink capacitance	С		f = 1.0 MHz	-	12	-	
Total gate charge	Qg			-	-	14	
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$I_D = 4.8 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 b	-	-	3.0	nC
Gate-drain charge	Q_{gd}		See fig. 6 and 16	-	-	7.9	
Turn-on delay time	t _{d(on)}	$V_{DD} = 100 \text{ V}, I_D = 4.8 \text{ A}, \\ R_g = 18 \Omega, R_D = 20 \Omega, \\ \text{see fig. 10}^{\text{b}}$		-	7.2	-	- ns
Rise time	t _r			-	22	-	
Turn-off delay time	t _{d(off)}			=	19	-	
Fall time	t _f		2 300 lig. 10		13	-	
Gate input resistance	R _g	f = 1	f = 1 MHz, open drain		-	3.5	Ω
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal source inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	cs						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.1	A
Pulsed diode forward current ^a	I _{SM}			-	-	16	_ ^
Body diode voltage	V _{SD}	T _J = 25 °C	T _J = 25 °C, I _S = 4.1 A, V _{GS} = 0 V ^b		-	1.8	V
Body diode reverse recovery time	t _{rr}	T _ 05 °C 1	- 4 9 A dl/dt - 100 A/: h	-	150	300	ns
Body diode reverse recovery charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 4.8 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^{\text{b}}$		-	0.91	1.8	μC
Forward turn-on time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

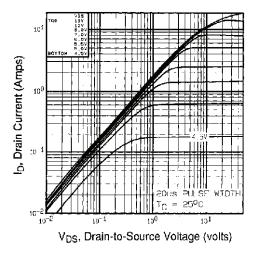


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

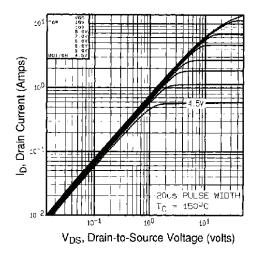


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

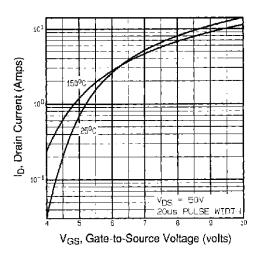


Fig. 3 - Typical Transfer Characteristics

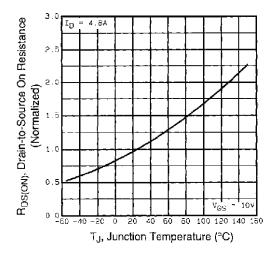


Fig. 4 - Normalized On-Resistance vs. Temperature



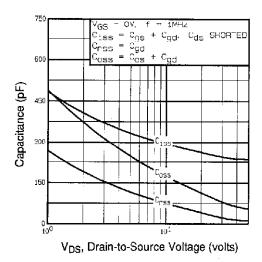


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

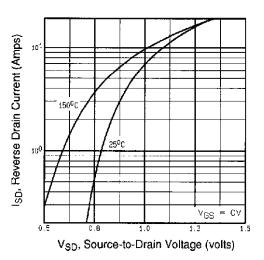


Fig. 7 - Typical Source-Drain Diode Forward Voltage

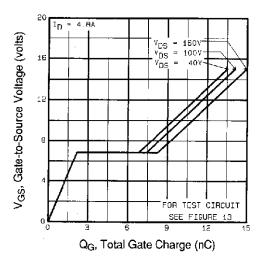


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

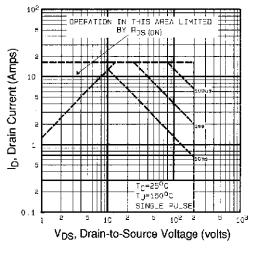


Fig. 8 - Maximum Safe Operating Area



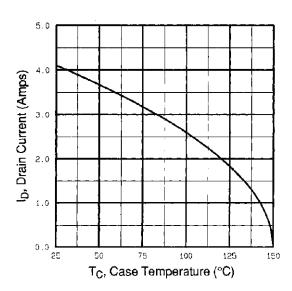


Fig. 9 - Maximum Drain Current vs. Case Temperature

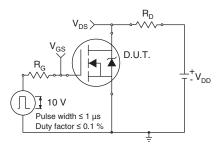


Fig. 10a - Switching Time Test Circuit

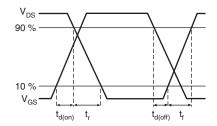


Fig. 10b - Switching Time Waveforms

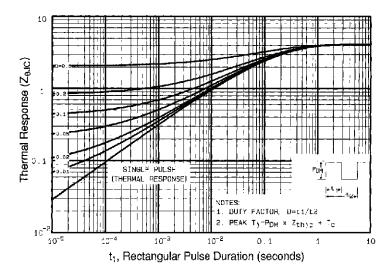


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

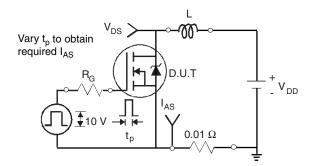


Fig. 12a - Unclamped Inductive Test Circuit

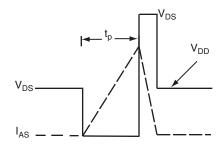


Fig. 12b - Unclamped Inductive Waveforms



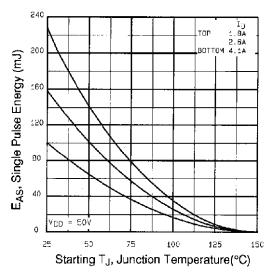


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

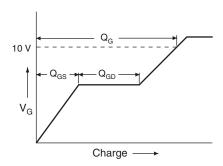


Fig. 13a - Basic Gate Charge Waveform

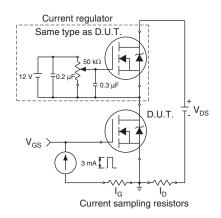
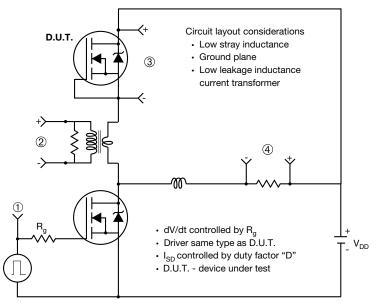


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



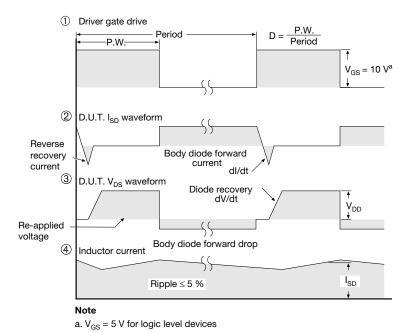


Fig. 14 - For N-Channel

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TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



	MILLIMETERS		
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIMETERS		INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.570	4.830	0.180	0.190		
A1	2.570	2.830	0.101	0.111		
A2	2.510	2.850	0.099	0.112		
b	0.622	0.890	0.024	0.035		
b2	1.229	1.400	0.048	0.055		
b3	1.229	1.400	0.048	0.055		
С	0.440	0.629	0.017	0.025		
D	8.650	9.800	0.341	0.386		
d1	15.88	16.120	0.622	0.635		
d3	12.300	12.920	0.484	0.509		
E	10.360	10.630	0.408	0.419		
е	2.54	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541		
L1	3.100	3.500	0.122	0.138		
n	6.050	6.150	0.238	0.242		
ØP	3.050	3.450	0.120	0.136		
u	2.400	2.500	0.094	0.098		
V	0.400	0.500	0.016	0.020		

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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- 3. All critical dimensions should C meet $C_{pk} > 1.33$
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- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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Vishay

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